Size effects on Pb_{0.5}Ca_{0.5}TiO₃ thin films

R. Jiménez, I. Bretos, J.Ricote, C. Alemany, M.L.Calzada and J.Mendiola *Inst. Ciencia de Materiales de Madrid, CSIC. Cantoblanco. 28049 – Madrid. Spain.*

Recent experimental finds on calcium lead titanate thin films, $Pb_{1-x}Ca_xTiO_3$, with x=0.5 reported by the authors [1,2] deal with their probably relaxor character and the coexistence of a mixture of orthorhombic, Pbmn, and tetragonal, P4mm, phases. Based on this knowledge, $Pb_{0.5}Ca_{0.5}TiO_3$ thin films with different thickness have been prepared by deposition of sol-gel precursor solutions onto $Pt/TiO_2/SiO_2/(100)Si$ substrates and crystallized by a rapid thermal processing (RTP). Dielectric measurements with temperature and frequency, and AFM micrographs have been performed. Two maxima are detected in the curve of variation of permittivity with temperature (K'-T), which are clearly observed in the thinner films. The AFM images of the films surfaces shows a non - dependence of the mean grain size (~ 50 nm) with the film thickness. Furthermore, relaxor - like properties are dependent on the film heterostructure (film thickness). The analysis of the experimental results and dielectric anomalies observed is discussed in terms of the possible existence of a morphotropic phase boundary (MPB) and strain/stress generated during their processing.

- [1] R. Jiménez, C. Alemany, M. L. Calzada and J. Mendiola. "Relaxor Like Behaviour of Pb_{0.5} Ca_{0.5} TiO₃ thin films". Ferroelectrics. In press.
- [2] I.Bretos, J.Ricote, R.Jiménez, J.Mendiola and M.L.Calzada. "Processing of chemical solution deposited Ca-modified PbTiO₃ films for high frequency components and dynamic random access memories" Integrated Ferroelectrics. In press.